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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 1 of 9

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Application Number	10/726,772
Filing Date	December 3, 2003
First Named Inventor	Nolte
Art Unit	1797
Examiner Name	Ramillano
Attorney Docket Number	12258-0021

U. S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US RE 33,581	04/30/1991	Nicoli et al.	
		US 3,796,495	03/12/1974	Laub	
		US 4,899,195	02/06/1990	Gotoh	
		US 5,497,007	03/05/1996	Uritsky et al.	
		US 5,581,345	12/03/1996	Oki et al.	
		US 5,602,377	02/11/1997	Beller et al.	
		US 5,621,532	04/15/1997	Ooki et al.	
		US 5,629,044	05/13/1997	Rubenchik	
		US 5,700,046	12/23/1997	Van Doren et al.	
		US 5,999,262	12/07/1999	Dobschal et al.	
		US 6,312,901	11/06/2001	Virtanen	
		US 6,483,588	11/19/2002	Graefe et al.	
		US 6,591,196	07/08/2003	Yakhini et al.	
		US 6,656,428	12/02/2003	Clark et al.	
		US 6,734,000	05/11/2004	Bhatia	
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		WO 0144441	06/21/2001	Biostar, Inc.		
		WO 0111310	02/15/2001	Biostar, Inc.		
		WO 9214136	08/20/1992	Biostar Medical Products		
		WO 9403774	02/17/1994	Biostar, Inc.		
		WO 0000265	01/06/2000	Biostar, Inc.		
		WO 0039584	07/06/2000	Biostar, Inc.		

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Sheet 3 of 9

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Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
		NAGARAJAN, R., Intensity-based segmentation of microarrays images. IEEE Trans. Med. Imaging. v22. 882-889 (2003).	
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		D. S. GERBER, R. DROOPAD, AND G. N. MARACAS, "A GaAs/AlGaAs Asymmetric Fabry-Perot Reflection Modulator with very High Contrast Ratio," <i>IEEE Phot. Tech. Lett.</i> , vol. 5, pp. 55-58, 1993.	
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Examiner Name	Ramillano
Attorney Docket Number	12258-0021

Sheet 7 of 9

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Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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Application Number	10/726,772
Filing Date	December 3, 2003
First Named Inventor	Nolte
Art Unit	1797
Examiner Name	Ramillano
Attorney Docket Number	12258-0021

Sheet 8 of 9

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